Small switching

QS6M3

●Features

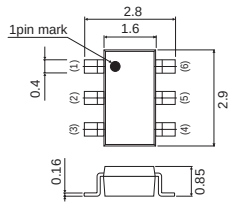
1) Low on-resistance.
2) Built-in G-S Protection Diode.
3) Small and Surface Mount Package (TSMT6).

●Application

Power switching, DC / DC converter.

●External dimensions (Unit : mm)

TSMT6



Each lead has same dimensions

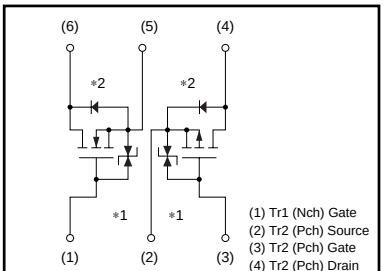
Abbreviated symbol : MO3

●Absolute maximum ratings (Ta=25°C)

Parameter		Symbol	Limits		Unit
			Tr1 : Nch	Tr2 : Pch	
Drain-source voltage		V_{DSS}	30	−20	V
Gate-source voltage		V_{GSS}	12	−12	V
Drain current	Continuous	I_D	±1.5	±1.5	A
	Pulsed	I_{DP}	±6.0	±6.0	A *1
Source current (Body diode)	Continuous	I_S	0.8	−0.75	A
	Pulsed	I_{SP}	6.0	−6.0	A *1
Total power dissipation (T_C=25°C)		P_D	1.25	1.25	W / Total *2
Channel temperature		Tch	150	150	°C
Storage temperature		Tstg	−55 to +150	−55 to +150	°C

*1 Pw≤10μs, Duty cycle≤1%
*2 Mounted on a ceramic board

●Equivalent circuit



*1 ESD PROTECTION DIODE
*2 BODY DIODE

●Thermal resistance (Ta=25°C)

Parameter	Symbol	Limits	Unit
Channel to ambient	Rth (ch-A)	100	°C / W / Total *

* Mounted on a ceramic board

●**Electrical characteristics** (Ta=25°C)

<Tr1. N-ch MOSFET>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	I_{GSS}	–	–	10	μA	V_{GS}=12V, V_{DS}=0V
Drain-source breakdown voltage	$V_{(BR)\ DSS}$	30	–	–	V	I_D=1mA, V_{GS}=0V
Zero gate voltage drain current	I_{DSS}	–	–	1	μA	V_{DS}=30V, V_{GS}=0V
Gate threshold voltage	$V_{GS\ (th)}$	0.5	–	1.5	V	V_{DS}=10V, I_D=1mA
Static drain-source on-state resistance	$R_{DS\ (on)}$ *	–	170	230	mΩ	I_D=1.5A, V_{GS}=4.5V
		–	180	245		I_D=1.5A, V_{GS}=4.0V
		–	260	360		I_D=1.0A, V_{GS}=2.5V
Forward transfer admittance	$\|Y_{fs}\|$ *	1.0	–	–	S	I_D=1.0A, V_{DS}=10V
Input capacitance	C_{iss}	–	80	–	pF	V_{DS}=10V
Output capacitance	C_{oss}	–	25	–	pF	V_{GS}=0V
Reverse transfer capacitance	C_{rss}	–	15	–	pF	f=1MHz
Turn-on delay time	$t_{d\ (on)}$ *	–	7	–	ns	I_D=1A, V_{DD}≒15V
Rise time	t_r *	–	18	–	ns	V_{GS}=4.5V
Turn-off delay time	$t_{d\ (off)}$ *	–	15	–	ns	R_L=15Ω
Fall time	t_f *	–	15	–	ns	R_{GS}=10Ω
Total gate charge	Q_g *	–	1.6	–	nC	V_{DD}≒15V R_L=10Ω
Gate-source charge	Q_{gs} *	–	0.5	–	nC	V_{GS}=4.5V R_{GS}=10Ω
Gate-drain charge	Q_{gd} *	–	0.9	–	nC	I_D=1.5A

*Pulsed

●**Body diode characteristics** (Source-Drain)

<Tr1. N-ch MOSFET>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	V_{SD} *	–	–	1.2	V	I_S=3.2A, V_{GS}=0V

*Pulsed

●**Electrical characteristics** (Ta=25°C)

<Tr2. P-ch MOSFET>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	I_{GSS}	–	–	–10	μA	V_{GS}= –12V, V_{DS}=0V
Drain-source breakdown voltage	$V_{(BR)\ DSS}$	–20	–	–	V	I_D= –1mA, V_{GS}=0V
Zero gate voltage drain current	I_{DSS}	–	–	–1	μA	V_{DS}= –20V, V_{GS}=0V
Gate threshold voltage	$V_{GS\ (th)}$	–0.7	–	–2.0	V	V_{DS}= –10V, I_D=1mA
Static drain-source on-state resistance	$R_{DS\ (on)}$ *	–	155	215	mΩ	I_D= –1.5A, V_{GS}= –4.5V
		–	170	235		I_D= –1.5A, V_{GS}= –4.0V
		–	310	430		I_D= –0.75A, V_{GS}= –2.5V
Forward transfer admittance	$\|Y_{fs}\|$ *	1.0	–	–	S	I_D= –0.75A, V_{DS}= –10V
Input capacitance	C_{iss}	–	270	–	pF	V_{DS}= –10V
Output capacitance	C_{oss}	–	40	–	pF	V_{GS}=0V
Reverse transfer capacitance	C_{rss}	–	35	–	pF	f=1MHz
Turn-on delay time	$t_{d\ (on)}$ *	–	10	–	ns	I_D= –0.75A, V_{DD}≒ –15V
Rise time	t_r *	–	12	–	ns	V_{GS}= –4.5V
Turn-off delay time	$t_{d\ (off)}$ *	–	45	–	ns	R_L=20Ω
Fall time	t_f *	–	20	–	ns	R_{GS}=10Ω
Total gate charge	Q_g *	–	3.0	–	nC	V_{DD}≒ –15V R_L=10Ω
Gate-source charge	Q_{gs} *	–	0.8	–	nC	V_{GS}= –4.5V R_{GS}=10Ω
Gate-drain charge	Q_{gd} *	–	0.85	–	nC	I_D= –1.5A

*Pulsed

●**Body diode characteristics** (Source-Drain)

<Tr2. P-ch MOSFET>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	V_{SD} *	–	–	–1.2	V	I_S= –0.75A, V_{GS}=0V

*Pulsed

N-ch

●Electrical characteristic curves

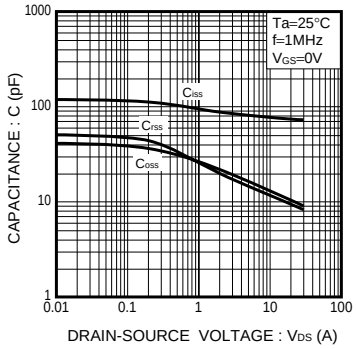


Fig.1 Typical Capacitance vs. Drain-Source Voltage

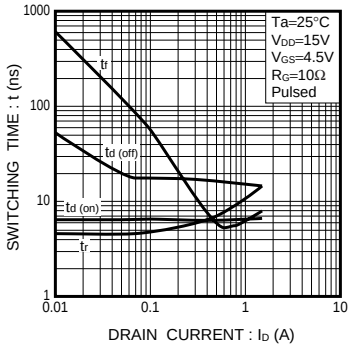


Fig.2 Switching Characteristics

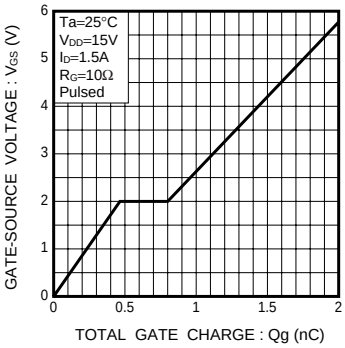


Fig.3 Dynamic Input Characteristics

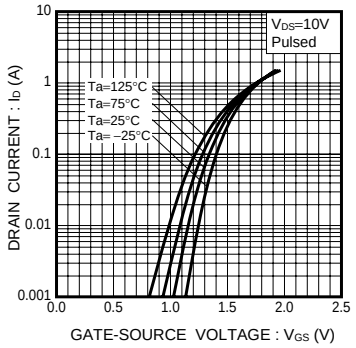


Fig.4 Typical Transfer Characteristics

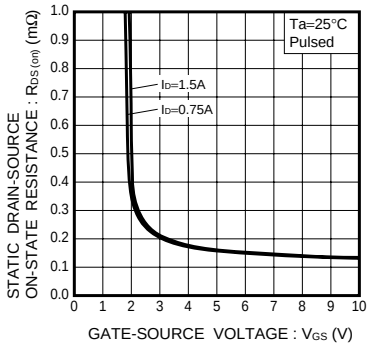


Fig.5 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

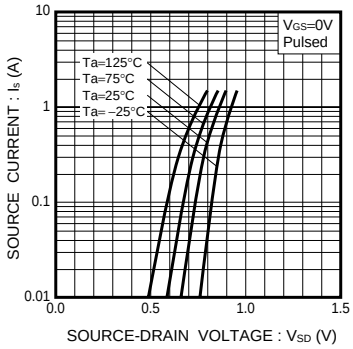


Fig.6 Source Current vs. Source-Drain Voltage

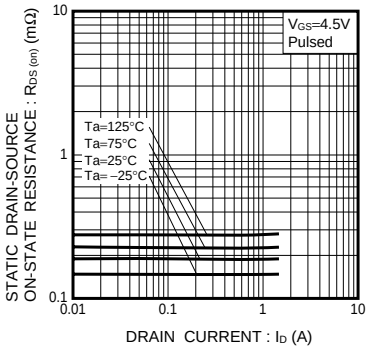


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current (I)

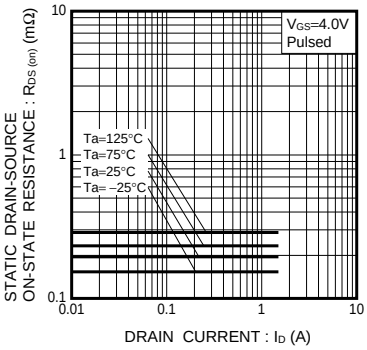


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current (II)

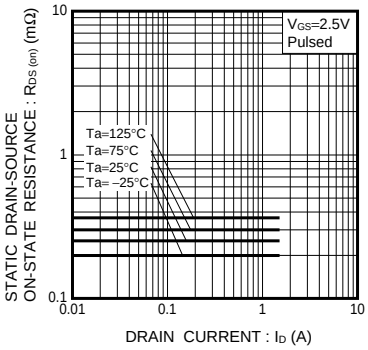


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current (III)

P-ch

●Electrical characteristic curves

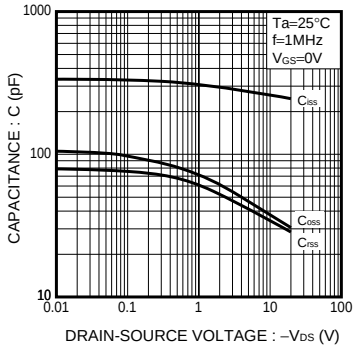


Fig.1 Typical Capacitance vs. Drain-Source Voltage

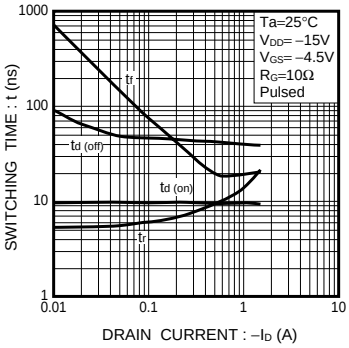


Fig.2 Switching Characteristics

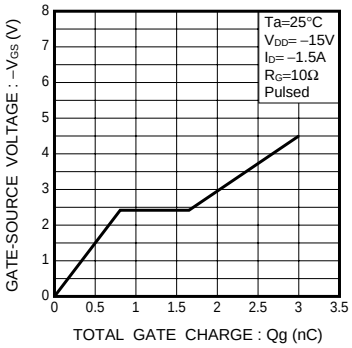


Fig.3 Dynamic Input Characteristics

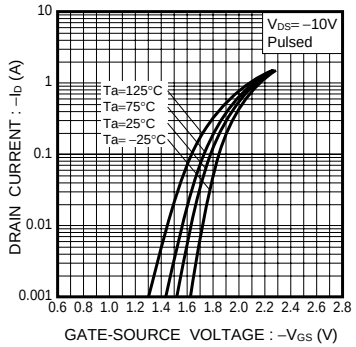


Fig.4 Typical Transfer Characteristics

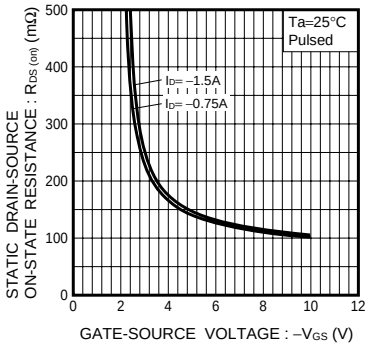


Fig.5 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

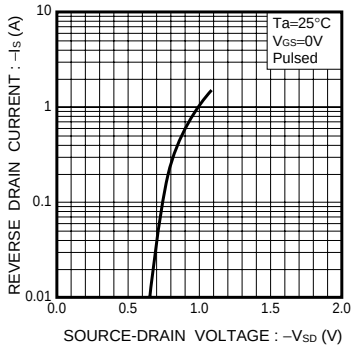


Fig.6 Source Current vs. Source-Drain Voltage

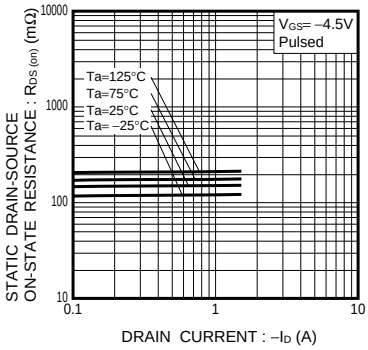


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current (I)

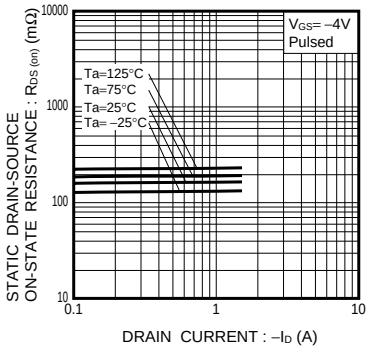


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current (II)

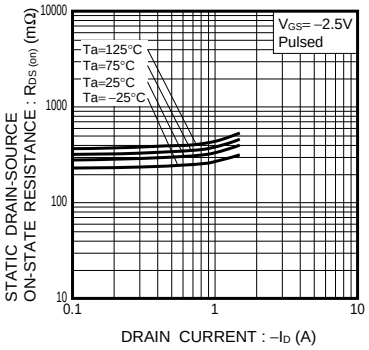


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current (III)

N-ch

●Measurement circuit

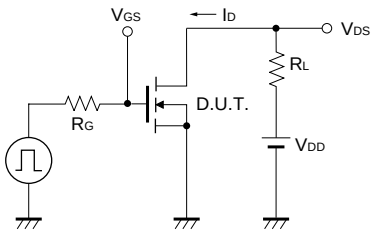


Fig.1-1 Switching Time Measurement Circuit

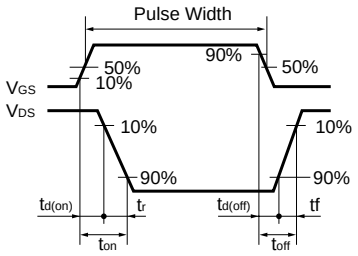


Fig.1-2 Switching Waveforms

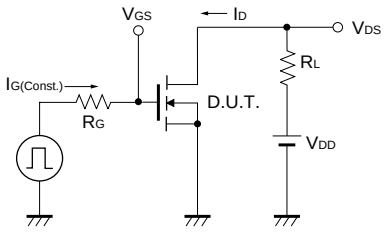


Fig.2-1 Gate Charge Measurement Circuit

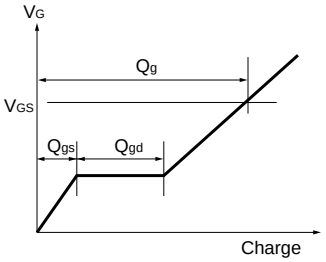


Fig.2-2 Gate Charge Waveform

P-ch

●Measurement circuit

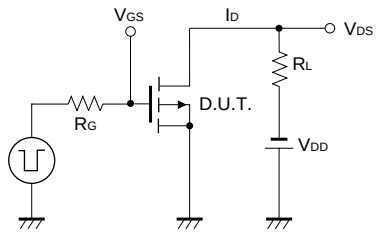


Fig.3-1 Switching Time Measurement Circuit

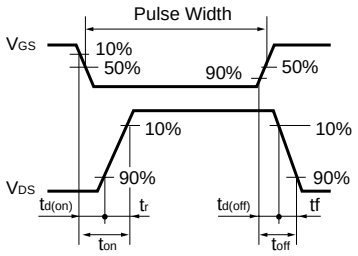


Fig.3-2 Switching Waveforms

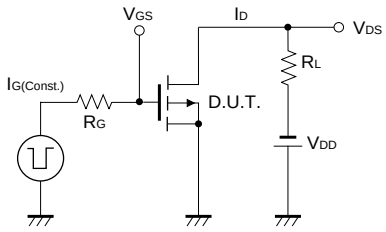


Fig.4-1 Gate Charge Measurement Circuit

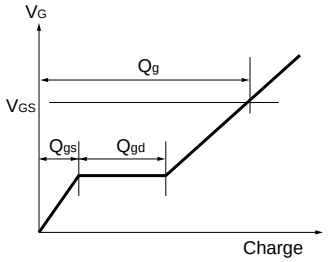


Fig.4-2 Gate Charge Waveform

Notes

- No technical content pages of this document may be reproduced in any form or transmitted by any means without prior permission of ROHM CO.,LTD.
- The contents described herein are subject to change without notice. The specifications for the product described in this document are for reference only. Upon actual use, therefore, please request that specifications to be separately delivered.
- Application circuit diagrams and circuit constants contained herein are shown as examples of standard use and operation. Please pay careful attention to the peripheral conditions when designing circuits and deciding upon circuit constants in the set.
- Any data, including, but not limited to application circuit diagrams information, described herein are intended only as illustrations of such devices and not as the specifications for such devices. ROHM CO.,LTD. disclaims any warranty that any use of such devices shall be free from infringement of any third party's intellectual property rights or other proprietary rights, and further, assumes no liability of whatsoever nature in the event of any such infringement, or arising from or connected with or related to the use of such devices.
- Upon the sale of any such devices, other than for buyer's right to use such devices itself, resell or otherwise dispose of the same, no express or implied right or license to practice or commercially exploit any intellectual property rights or other proprietary rights owned or controlled by
- ROHM CO., LTD. is granted to any such buyer.
- Products listed in this document use silicon as a basic material.
  Products listed in this document are no antiradiation design.

The products listed in this document are designed to be used with ordinary electronic equipment or devices (such as audio visual equipment, office-automation equipment, communications devices, electrical appliances and electronic toys).
Should you intend to use these products with equipment or devices which require an extremely high level of reliability and the malfunction of with would directly endanger human life (such as medical instruments, transportation equipment, aerospace machinery, nuclear-reactor controllers, fuel controllers and other safety devices), please be sure to consult with our sales representative in advance.

About Export Control Order in Japan

Products described herein are the objects of controlled goods in Annex 1 (Item 16) of Export Trade Control Order in Japan.
In case of export from Japan, please confirm if it applies to "objective" criteria or an "informed" (by MITI clause) on the basis of "catch all controls for Non-Proliferation of Weapons of Mass Destruction.